


<b>Search Notes</b> 	<b>Application/Control No.</b> 10802914	<b>Applicant(s)/Patent Under Reexamination</b> FUNAHASHI ET AL.
	<b>Examiner</b> Rutz, Jared I	<b>Art Unit</b> 2187

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
text and text limited classification search in EAST, see search history	3/14/07	jlr
consulted Kevin Ellis	3/13/07	jlr
consulted Brian Peugh	3/14/07	jlr
updated search in EAST, see search history	9/19/2007	jlr
updated search in EAST, see search history	4/9/2008	jlr
internet search using google.com and scholar.google.com	4/9/2008	jlr
consulted Brian Peugh re: restriction	4/9/2008	jlr

INTERFERENCE SEARCH			
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